

## MOSFET Silicon N-Channel MOS

### 1. Applications

Single-ended flyback or two-transistor forward topologies.  
PC power, PD Adaptor, LCD & PDP TV and LED lighting.



### 2. Features

Low drain-source on-resistance:  $R_{DS(ON)} = 230\text{m}\Omega$  (typ.)  
Easy to control Gate switching  
Enhancement mode:  $V_{th} = 2.8$  to  $4.2\text{ V}$

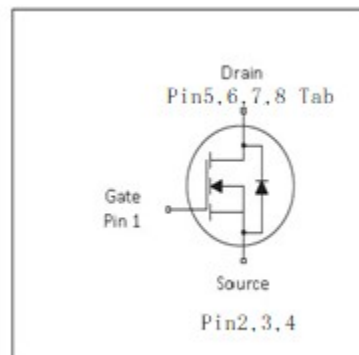
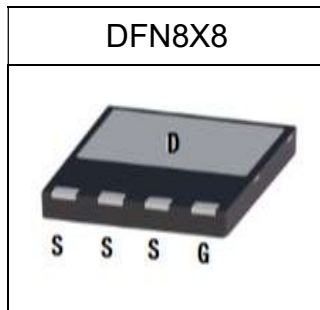


**Table 1 Key Performance Parameters**

Parameter	Value	Unit
$V_{DS} @ T_{j,max}$	700	V
$R_{DS(on),max}$	265	$\text{m}\Omega$
$Q_{g,typ}$	23.2	nC
$I_{D,pulse}$	58	A

### 3. Packaging and Internal Circuit

Part Name	Package	Marking
ASM65R265E	DFN8X8	ASM65R265E



## 1 Maximum ratings

at  $T_j = 25^\circ\text{C}$ , unless otherwise specified

**Table 2 Maximum ratings**

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Continuous drain current <sup>1)</sup>	$I_D$		-	15	A	$T_C=25^\circ\text{C}$
Pulsed drain current <sup>2)</sup>	$I_{D,pulse}$	-	-	58	A	$T_C=25^\circ\text{C}$
Avalanche energy, single pulse	$E_{AS}$	-	-	198	mJ	$T_C=25^\circ\text{C}$ , $V_{DD}=50\text{V}$ , $I_D=6.3\text{A}$ , $L=10\text{mH}$ , $R_G=25\Omega$
Avalanche current, single pulse	$I_{AR}$	-	-	6.3	A	$T_C=25^\circ\text{C}$ , $V_{DD}=50\text{V}$ , $L=10\text{mH}$ , $R_G=25\Omega$
Gate source voltage (static)	$V_{GS}$	-30	-	30	V	static;
Power dissipation	$P_{tot}$	-	-	125	W	$T_C=25^\circ\text{C}$
Storage temperature	$T_{stg}$	-55	-	150	$^\circ\text{C}$	
Operating junction temperature	$T_j$	-55	-	150	$^\circ\text{C}$	

<sup>1)</sup> Limited by  $T_{j,max}$ . Maximum Duty Cycle  $D = 0.50$

<sup>2)</sup> Pulse width  $t_p$  limited by  $T_{j,max}$

<sup>3)</sup> Identical low side and high side switch with identical  $R_G$

## 2 Thermal characteristics

### Thermal characteristics

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Thermal resistance, junction - case	$R_{thJC}$	-	-	0.71	°C/W	-
Thermal resistance, junction - ambient	$R_{thJA}$	-	-	62	°C/W	device on PCB, minimal footprint

## 3 Electrical characteristics

at  $T_j=25^{\circ}\text{C}$ , unless otherwise specified

**Table 4 Static characteristics**

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Drain-source breakdown voltage	$V_{(BR)DSS}$	650	-	-	V	$V_{GS}=0V, I_D=250\mu A$
Gate threshold voltage	$V_{(GS)th}$	2.8		4.2	V	$V_{DS}=V_{GS}, I_D=250\mu A$
Zero gate voltage drain current	$I_{DSS}$	-	-	1	$\mu A$	$V_{DS}=650V, V_{GS}=0V, T_j=25^{\circ}\text{C}$
Gate-source leakage current	$I_{GSS}$	-	-	100	nA	$V_{GS}=30V, V_{DS}=0V$
Drain-source on-state resistance	$R_{DS(on)}$	-	230	265	m $\Omega$	$V_{GS}=10V, I_D=5.5A, T_j=25^{\circ}\text{C}$
Gate resistance (Intrinsic)	$R_G$	-	32	-	$\Omega$	$f=1\text{MHz}$ , open drain

**Table 5 Dynamic characteristics**

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Input capacitance	$C_{iss}$	-	1160	-	pF	$V_{GS}=0V, V_{DS}=400V, f=250\text{kHz}$
Output capacitance	$C_{oss}$	-	29.1	-	pF	$V_{GS}=0V, V_{DS}=400V, f=250\text{kHz}$
Reverse transfer capacitance	$C_{rss}$	-	0.8	-	pF	$V_{GS}=0V, V_{DS}=400V, f=250\text{kHz}$
Turn-on delay time	$t_{d(on)}$	-	21.8	-	ns	$V_{DD}=400V, V_{GS}=13V, I_D=5.2A, R_G=10.2\Omega$
Rise time	$t_r$	-	23.4	-	ns	$V_{DD}=400V, V_{GS}=13V, I_D=5.2A, R_G=10.2\Omega$
Turn-off delay time	$t_{d(off)}$	-	122.8	-	ns	$V_{DD}=400V, V_{GS}=13V, I_D=5.2A, R_G=10.2\Omega$
Fall time	$t_f$	-	21.4	-	ns	$V_{DD}=400V, V_{GS}=13V, I_D=5.2A, R_G=10.2\Omega$

**Table 6 Gate charge characteristics**

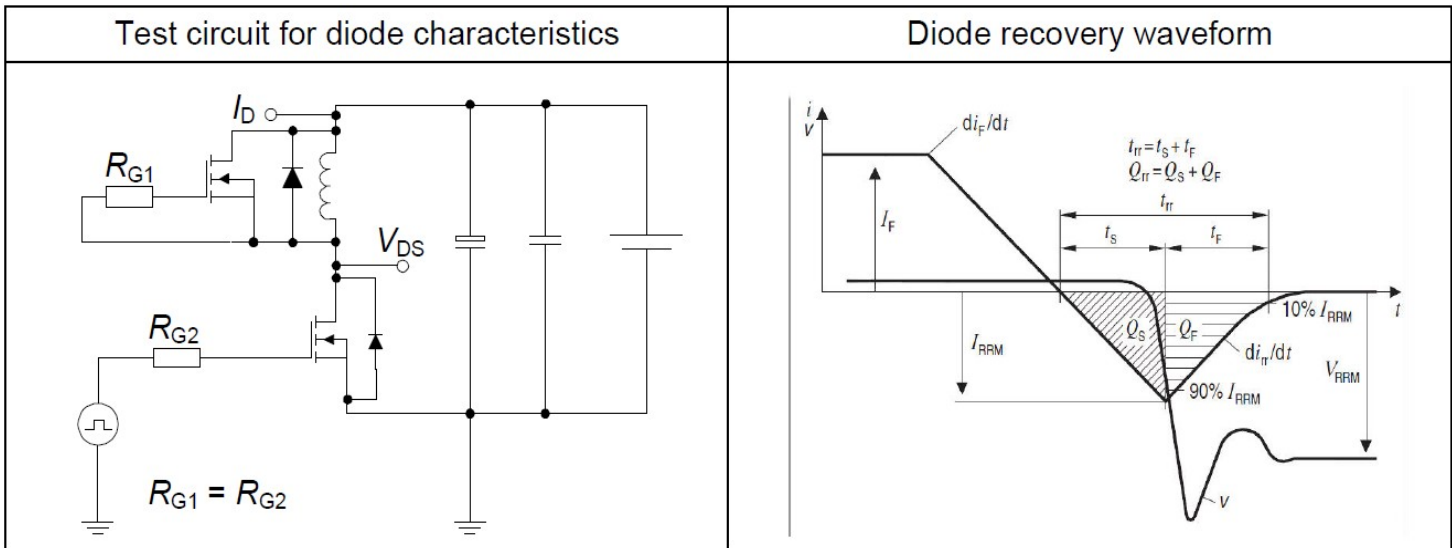
Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Gate to source charge	$Q_{gs}$	-	5.4	-	nC	$V_{DD}=400V, I_D=5.2A, V_{GS}=0$ to 10V
Gate to drain charge	$Q_{gd}$	-	8.1	-	nC	$V_{DD}=400V, I_D=5.2A, V_{GS}=0$ to 10V
Gate charge total	$Q_g$	-	23.2	-	nC	$V_{DD}=400V, I_D=5.2A, V_{GS}=0$ to 10V

**Table 7 Reverse diode characteristics**

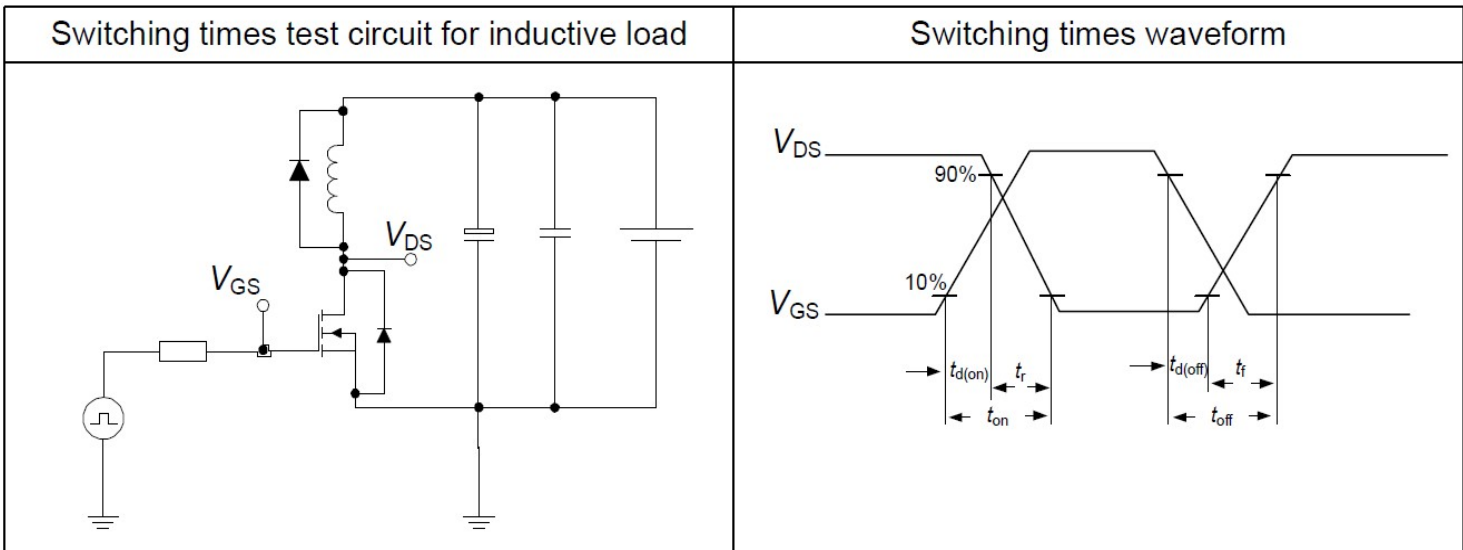
Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Diode forward voltage	$V_{SD}$	-	0.74	-	V	$V_{GS}=0V, I_F=1A, T_j=25^{\circ}C$
Reverse recovery time	$t_{rr}$	-	210.5	-	ns	$V_R=400V, I_F=5.2A, di_F/dt=100A/\mu s$
Reverse recovery charge	$Q_{rr}$	-	1.7	-	uC	$V_R=400V, I_F=5.2A, di_F/dt=100A/\mu s$
Peak reverse recovery current	$I_{rrm}$	-	18	-	A	$V_R=400V, I_F=5.2A, di_F/dt=100A/\mu s$

## 4 Test Circuits

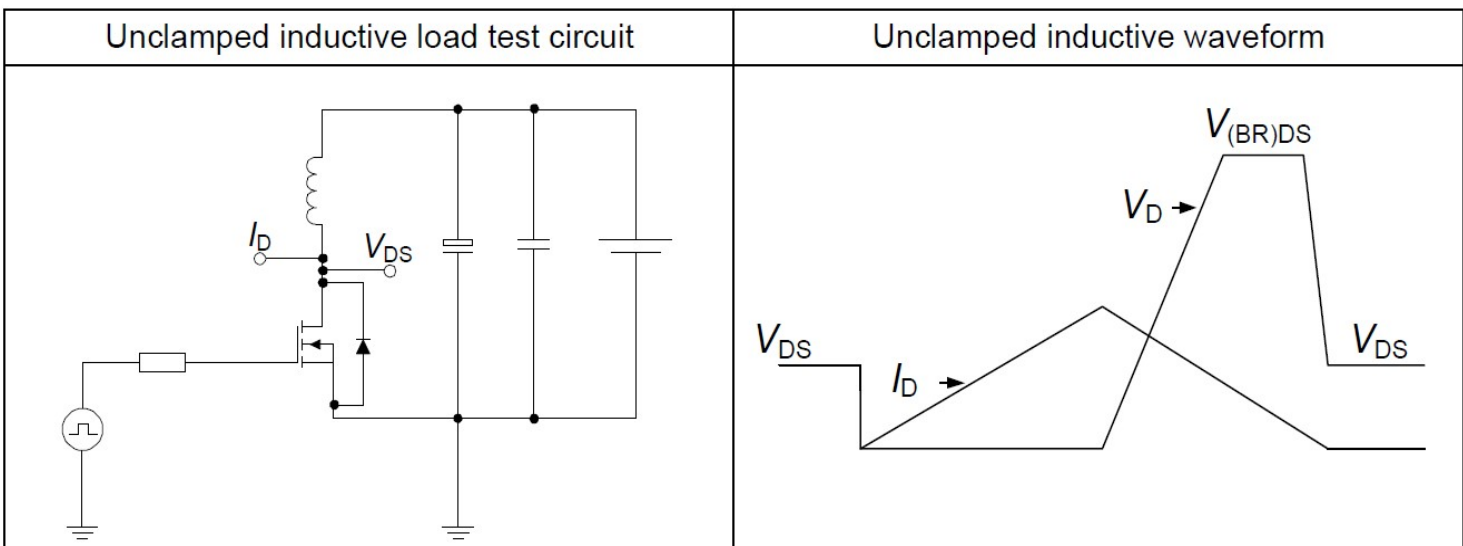
**Table 8 Diode characteristics**



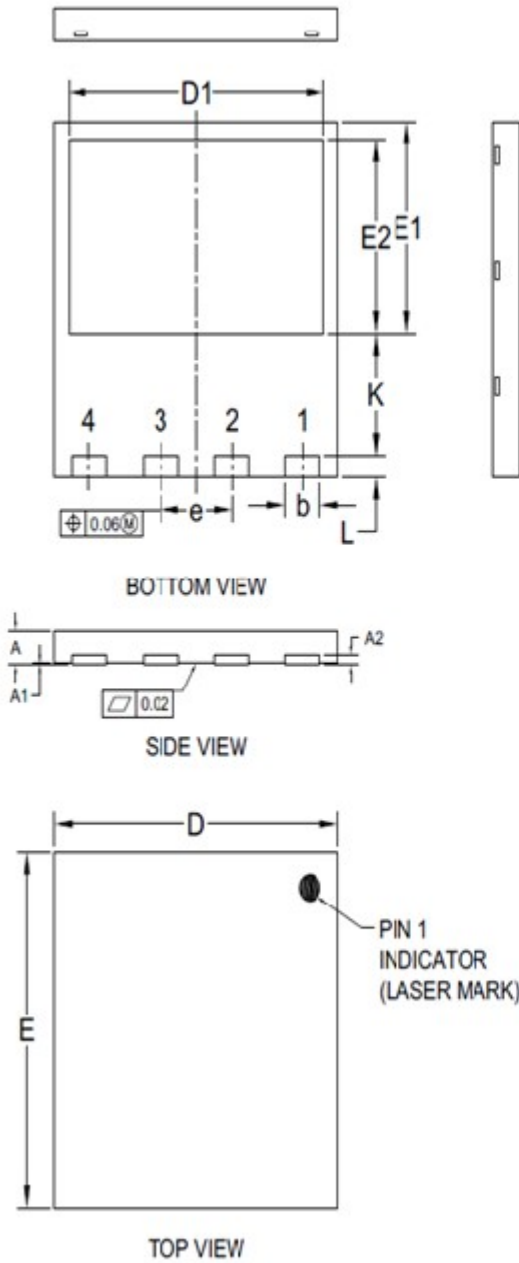
**Table 9 Switching times**



**Table 10 Unclamped inductive load**



5 Package Outlines



COMMON DIMENSIONS  
(UNITS OF MEASURE=MILLIMETER)

SYMBOL	MIN	TYP	MAX
A	0.70	0.8	0.9
A1	0.00	—	0.05
A2	0.20REF		
b	0.90	1.00	1.10
D	7.90	8.00	8.10
D1	7.10	7.20	7.30
E	7.90	8.00	8.10
E1	4.65	4.75	4.85
E2	4.25	4.35	4.45
e	2.00BSC		
L	0.40	0.50	0.60
K	2.65	—	—

NOTES:  
 1. CONTROLLING DIMENSIONS ARE IN MILLIMETERS (ANGLES IN DEGREES).  
 2. COPLANARITY APPLIES TO THE EXPOSED PAD AS THE TERMINALS.

## Revision History

Revision	Date	Subjects (major changes since last revision)
1.0	2021-11-22	Preliminary version
1.1	2021-12-06	Updated Outline PG